

Notice of References Cited	Application/Control No. 09/744,149		Applicant(s)/Patent Under Reexamination BECHER ET AL.	
	Examiner John T. Haran		Art Unit 1733	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	E	US-4,882,399	11-1989	Tesoro et al.	525/523
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*	G	US-4,599,273	07-1986	Eian et al.	428/412
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NON-PATENT DOCUMENTS

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	U	http://www.furakawa.co.jp/uvtape/en/siyoun.htm
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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